Se	arch	Note	es .

Applica	tion/Con	trol No.
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Applicant(s)/Patent under Reexamination

10/823,129

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ZHAO ET AL.
Art Unit

Examiner
Huyen X. Vo

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	SEAR	CHED	
Class	Subclass	Date	Examiner
704	258; 214; 231; 232; 240; 242	2/6/2008	HV
704	257; 243	2/6/2008	HV
704	245; 244	2/6/2008	HV
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
EAST search included	2/6/2008	HV
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